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Substitute Form PT0-1449 (Modified)  U.S. Department of Commerce atlant and Trademark Office	Attomey's Docket No. 14342-002001	Application No. 10/685,870
Information Disclosure Statement by Applicant	Applicant Qian Shi, et al.	
(Use several sheets if necessary) (37 CFR §1.98(b))	Filing Date October 14, 2003	Group Art Unit

			U.S. Pate	ent Documents			<u> </u>
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
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	Other Documents (include Author, Title, Date, and Place of Publication)						
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Examiner Signature	Date Considered
T. A. Solola	12-10-64
EXAMINER: Initials citation considered. Drawline through citation if no next communication to applicant.	t in conformance and not considered. Include copy of this form with

Sheet	1	of	1
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Substitute Form PTO-1449 RMadified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 14342-002001	Application No. 10/685,870
Information Disclosure Statement by Applicant		Applicant Qian Shi, et al.	
(Use several si	neets if necessary)	Filing Date October 14, 2003	Group Art Unit

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	Other Do	ocuments (include Author, Title, Date, and Place of Publication)
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Examiner Signature	Date Considered
T. A. Solola	12-10-04
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